

N and P-Channel Enhancement Mode Power MOSFET

Features

N-Channel

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	Ι _D
30V	+20V	13mΩ@10V	36A
300	V	20mΩ@4.5V	30/4

P-Channel

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	I _D
-30V	+20V	22mΩ@-10V	-28A
-30 V	<u> </u>	30mΩ@-4.5V	-20/

> Description

The SSCU3628NP30GN6 uses advanced trench technology to provide excellent RDS(ON) and low gate charge. The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

100% UIS + ΔVDS + Rg Tested!

Applications

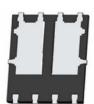
- PWM Applications
- Load Switch
- DC-DC Converters
- Wireless Chargers

Ordering Information

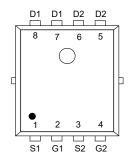
Device	Package	Shipping	
SSCU3628NP30GN6	PDFN5X6-8L	5000/Reel	

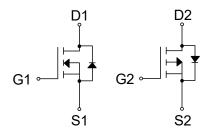
Pin configuration





PDFN5X6-8L





Pin Configuration (Top View)



Marking

(XXYY: Internal Traceability Code)



➤ Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter		N-Channel	P-Channel	Unit
V _{DSS}	Drain-to-Source Vol	Drain-to-Source Voltage		-30	V
V _{GSS}	Gate-to-Source Vol	tage	±20	±20	V
	Continuous Dusin Comment d	T _C =25℃	36	-28	۸
l _D	Continuous Drain Current d	Tc=100°C	19	-15	Α
	Continuous Dunin Comment 2	T _A =25°C	9	-7	Δ
IDSM	Continuous Drain Current ^a	T _A =70°C	6.5	-5	Α
Ірм	Pulsed Drain Current ^b		144	-112	Α
Б		Tc=25℃	45	42	147
P _D	Power Dissipation ^c	Tc=100°C	18	17	W
Б	Davis Diagination 2	T _A =25℃	3	3	14/
P _{DSM}	Power Dissipation ^a	T _A =70℃	1.9	1.9	W
las	Avalanche Current ^b L=0.5mH Single Pulse		11	-12	Α
Eas	Avalanche Energy ^b L=0.5mH Single Pulse		30	36	mJ
TJ	Operation junction temperature		-55~150		°C
T _{STG}	Storage temperature range		-55^	~150	$^{\circ}$

➤ Thermal Resistance Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Max.	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance a	42	53	°C/W
R ₀ JC	Junction-to-Case Thermal Resistance	2.8	4	C/VV

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper,in a still air environment with T_A=25 °C. The value in any given application depends on the user is specific board design. The current rating is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.

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➤ N-Channel Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250uA	30			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250$ uA	1	1.6	2.2	V
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 8A		13	20	mΩ
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5V, I _D = 6A		20	29	mΩ
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30V, V _{GS} = 0V			1	uA
Gate-Source Leak Current	Igss	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = 8A		0.7	1.3	V
Gate Resistance	R _G	V _{DS} =0V, f=1MHz		2		Ω
Input Capacitance	Ciss	V = 45V V = 0V		738		
Output Capacitance	Coss	$V_{DS} = 15V, V_{GS} = 0V,$		85		pF
Reverse Transfer Capacitance	C _{RSS}	f = 1MHz		69		
Total Gate Charge	Q _G)/ 40)/)/ 45)/		16		
Gate to Source Charge	Q _{GS}	V _{GS} = 10V, V _{DS} = 15V,		4.8		nC
Gate to Drain Charge	Q _{GD}	- I _D = 5A		3.6		
Turn-on Delay Time	T _{D(ON)}			6		
Rise Time	Tr	V _{GS} = 10V, V _{DS} = 15V,		12.5		
Turn-off Delay Time	T _{D(OFF)}	$R_L = 1\Omega$, $R_{GEN} = 3\Omega$		16		ns
Fall Time	T _f			5		
Diode Recovery Time	Trr	1 - 404 4:/// 4004/		7		ns
Diode Recovery Charge	Qrr	I _F = 10A, di/dt = 100A/us		1.4		nC

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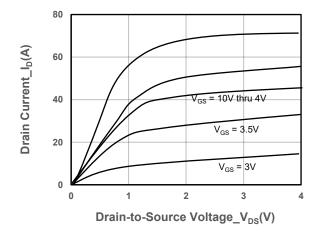


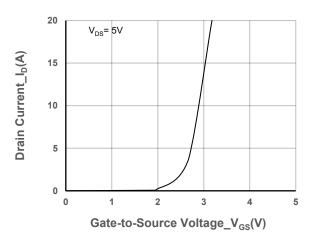
\triangleright P-Channel Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = -250uA	-30			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = -250uA$	-1	-1.7	-2.2	V
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = -10V, I _D = -8A		22	31	mΩ
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = -4.5V, I _D = -6A		30	50	mΩ
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -30V, V _{GS} = 0V			-1	μA
Gate-Source Leak Current	lgss	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = -8A		-0.7	-1.3	V
Gate Resistance	R _G	V _{DS} = 0V, f = 1MHz		11		Ω
Input Capacitance	Cıss	V = 45V V = 0V		871		
Output Capacitance	Coss	$V_{DS} = -15V$, $V_{GS} = 0V$, $f = 1MHz$		115		pF
Reverse Transfer Capacitance	C _{RSS}	I – IIVIMZ		91		
Total Gate Charge	Q _G	\(\(\) = 40\(\)\(\) = 45\(\)		18		
Gate to Source Charge	Q _G s	$V_{GS} = -10V, V_{DS} = -15V,$ $I_{D} = -5A$		3.5		nC
Gate to Drain Charge	Q _{GD}	ID3A		4		
Turn-on Delay Time	T _{D(ON)}			4		
Rise Time	Tr	V _{GS} = -10V, V _{DS} = -15V,		2.3		
Turn-off Delay Time	T _{D(OFF)}	I_D = -5A, R_{GEN} = 3Ω		38		ns
Fall Time	T _f			25		
Diode Recovery Time	Trr	I _F =-10A, di/dt=-100A/us		10		ns
Diode Recovery Charge	Qrr	I _F =-10A, di/dt=-100A/us		3		nC



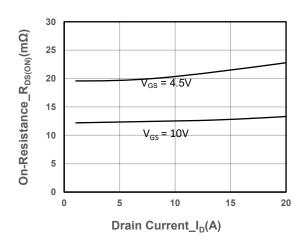
▶ N-Channel Typical Performance Characteristics (T_A=25°C unless otherwise noted)

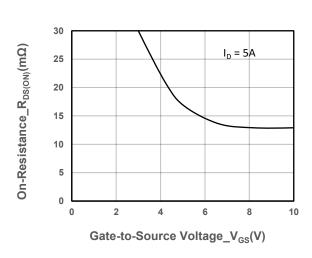




Output Characteristics

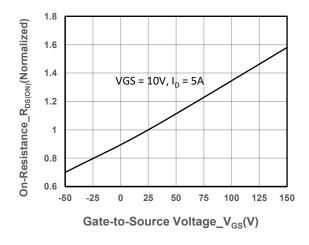


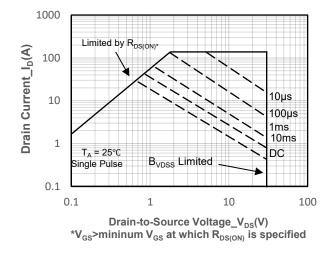




On-Resistance vs. Drain Current and Gate Voltag

On-Resistance vs. Gate-to-Source Voltage





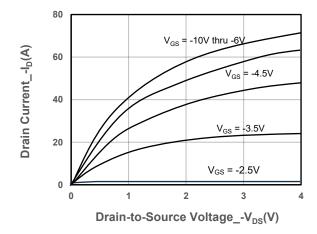
On-Resistance vs. Junction Temperature

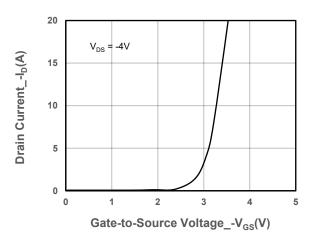
Safe Operating Area vs. Junction-to-Ambient

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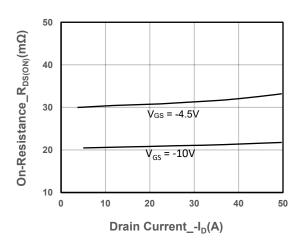
▶ P-Channel Typical Performance Characteristics (T_A=25°C unless otherwise noted)

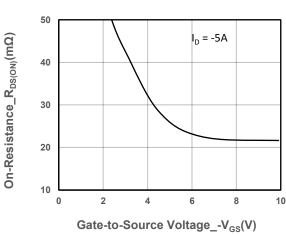




Output Characteristics

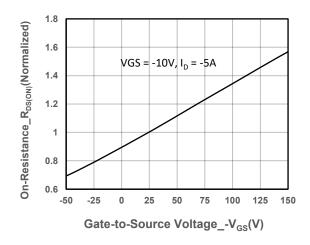
Transfer Characteristics

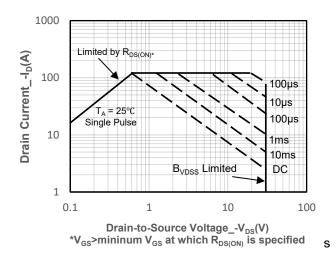




On-Resistance vs. Drain Current and Gate Voltag

On-Resistance vs. Gate-to-Source Voltage



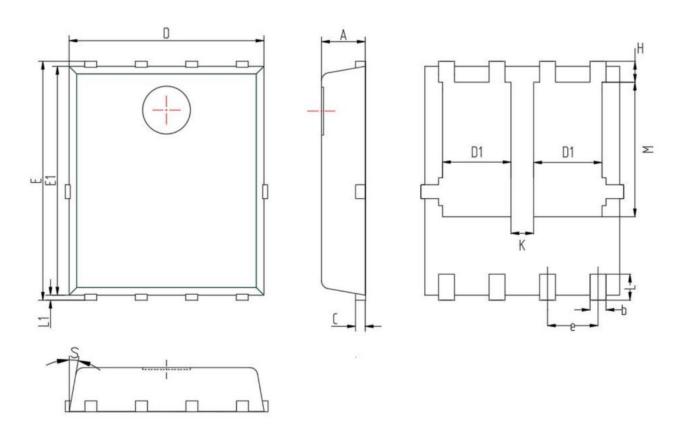


On-Resistance vs. Junction Temperature

Safe Operating Area vs. Junction-to-Ambient



> Package Information



Symbol	MILL IMETER			
Зуппон	Min	Nom	Max	
Α	0.9	1.10	1.20	
b	0.25	0.30	0.5	
С	0.20	0.25	0.35	
D	4.80	5.00	5.20	
D1	1.50	1.70	1.80	
Е	5.90	6.00	6.30	
E1	5.60	5.75	5.90	
е	1.27BSC			
Н	0.48	0.58	0.80	
K	0.50	0.60	0.70	
L	0.50	0.60	0.84	
L1	0.10	0.15	0.30	
M	3.30	3.48	3.67	
S	12° BSC			



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